Search	h Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/766,866	GUERET, JEAN-LOUIS	
Examiner	Art Unit	
David J. Walczak	3751	

SEARCHED				
Class	Subclass	Date	Examiner	
401	118, 126- 130	11/17/2005	DW	
215	252, 253			
	258			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH N (INCLUDING SEAR)		<u></u>
	DATE	EXMR
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